

(19) World Intellectual Property
Organization
International Bureau



(43) International Publication Date
27 May 2004 (27.05.2004)

PCT

(10) International Publication Number
WO 2004/044998 A2

(51) International Patent Classification⁷: **H01L 51/20**

(21) International Application Number:
PCT/CA2003/001742

(22) International Filing Date:
12 November 2003 (12.11.2003)

(25) Filing Language: English

(26) Publication Language: English

(30) Priority Data:
2,411,683 13 November 2002 (13.11.2002) CA

(71) Applicant (for all designated States except US): **LUX-ELL TECHNOLOGIES INC.** [CA/CA]; 2145 Meadowpine Blvd., Mississauga, Ontario L5N 6R8 (CA).

(72) Inventors; and

(75) Inventors/Applicants (for US only): **WOOD, Richard, P.** [CA/CA]; 121 Wellington Street, Delhi, Ontario N4B 1S6 (CA). **JOHNSON, David, J.** [CA/CA]; 60 Chatham Avenue, Toronto, Ontario M4J 1K6 (CA).

(74) Agent: **DE KLEINE, Geoffrey, B., C.**; Sim & McBurney, 330 University Avenue, 6th Floor, Toronto, Ontario M5G 1R7 (CA).

(81) Designated States (national): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.

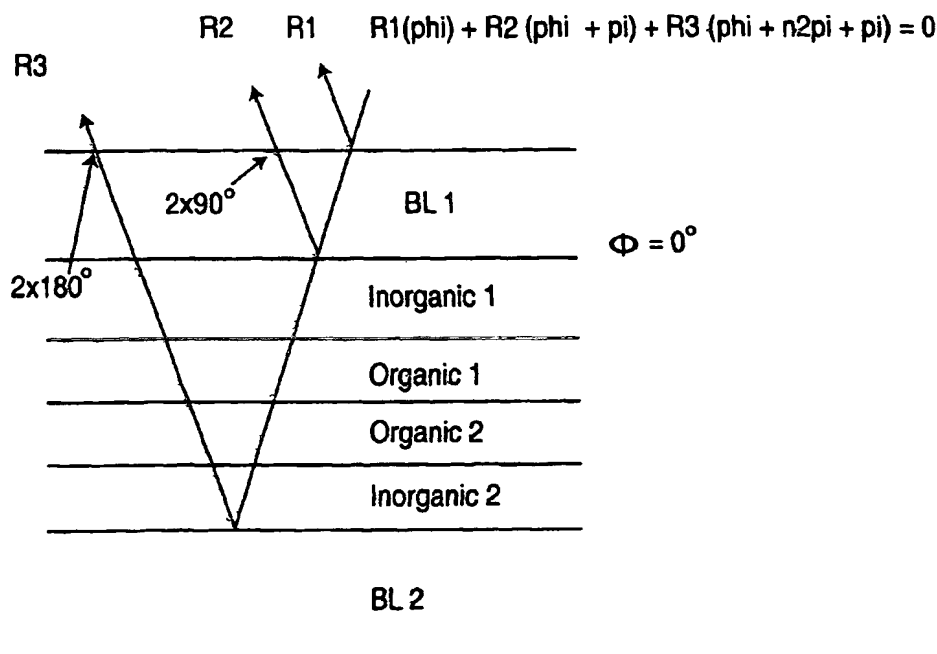
(84) Designated States (regional): ARIPO patent (BW, GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IT, LU, MC, NL, PT, RO, SE, SI, SK, TR), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

Published:

— without international search report and to be republished upon receipt of that report

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

(54) Title: **ORGANIC LIGHT EMITTING DIODE (OLED) WITH CONTRAST ENHANCEMENT FEATURES**



(57) Abstract: An organic electroluminescent device is provided having emitting layers with materials and thicknesses that provide constructive optical interference of emitted light. The device includes additional layers that provide contrast enhancement through destructive optical interference of ambient light entering the device.

BEST AVAILABLE COPY

WO 2004/044998 A2

Organic Light Emitting Diode (OLED) with Contrast Enhancement Features

Field of the Invention

- 5 The present invention relates to electroluminescent devices, and more particularly relates to contrast enhancement filters that are applied to electroluminescent devices.

Background of the Invention

- 10 Known contrast enhancement filters include optical interference filters as described in US5049780 to Dobrowoiski and US6411019 to Hofstra, the contents of which are incorporated herein by reference. In certain teachings of Dobrowolski and Hofstra contrast enhancement is provided by an optical interference member that is placed in front of a reflective rear electrode or reflective rear cathode. As more particularly
15 described therein, reflections of ambient light off of the rear electrode or rear cathode are used in conjunction with the optical interference member to create at least two, out-of-phase, wave forms of ambient light, which interfere with each other to cause at least some cancellation of each other and thereby reduce unwanted reflections of ambient light from the display.

- 20 Other known contrast enhancement filters include light absorbing materials that coat the reflective electrode or cathode. See, for example, WO 00/25028 to Berger et al, which contemplates the use of a graphite to coat a reflective rear cathode. These purely absorbing materials then reduce reflections of ambient light that enter the front
25 of the display, by effectively converting that ambient light into heat.

- However, these prior art structures may not be suitable where it is desired to actually utilize the reflectivity of the rear cathode in order to boost the amount of light emitted from the device. Put in other words, while the above-mentioned prior art devices
30 reduce ambient light that reaches the rear cathode of the display, the prior art devices also tend to reduce the light that is backwardly *emitted* towards the rear of the display. Indeed, in certain prior art OLED displays it is known to select an appropriate emitting region portion of the light emitting layer, to cooperate with the reflective

2

electrode, in order to achieve a total phase shift of rearwardly emitted light of about 360°, such that the two light waves constructively interfere, thereby enhancing the brightness of the device.

- 5 Presuming an ideal reflector and that the two light waves are thus equal in magnitude when they interfere, the intensity will be:

$$I_{rf} = (E_f + E_r)^2$$

$$E_f = E_r = E$$

- 10 $I_{rf} = 4E^2$, where E_f = electrical field of the forward emitted light and E_r = electrical field of the rear emitted light, and I_{rf} is the intensity seen by the viewer using a reflective rear electrode.

If E_r is absorbed, as is the case with a dark electrode, the equations become simply:

15

$$I_{dk} = (E_f + E_r)^2$$

$$E_f = E, E_r = 0$$

$I_{dk} = E^2$, where I_{dk} is the intensity seen by the viewer using a dark rear electrode. Thus $I_{dk}/I_{rf} = 1/4 = 0.25$ and the device using the dark rear electrode is only 25% as efficient

- 20 as the device using the reflective rear electrode.

- While it is known to reduce ambient light reflections in the above-described display using a circular polarizer applied to the front of the display, the circular polarizer has the additional effect of absorbing some of the emitted light, in some devices typically about 56 to about 62%, and in such devices the reflective rear electrode device is about 38% to about 44% efficient.

- PCT/CA03/00554 entitled Electroluminescent Device discloses a partially absorbing (semi-reflecting) layer, one or more light-emitting layers, and a fully reflecting layer that, in combination, give rise to a 180 ° phase shift of ambient light, along with constructive interference of light generated in the light-emitting layers. However, as with the other prior art systems discussed above, back reflection of the light generated

within the light emitting layers gives rise to destructive interference, which partially negates the advantages of the constructive interference.

Summary of the Invention:

5

It is therefore an object of the present invention to provide a display with contrast enhancement feature that mitigates or obviates at least one of the above-identified disadvantages of the prior art.

10 In an aspect of the present invention, there is provided an electroluminescent display that embeds the light emitting layers within the optical interference structure itself.

In particular, light-emissive organic layers are disposed between a semi-reflecting structure and a reflective structure, wherein the thickness and material of the semi-reflecting structure is chosen to cause at least some destructive optical interference of ambient light, while the thickness of the layers between the semi-reflecting structure and fully reflective structures is chosen to provide net 0 ° phase shift of ambient light passing through those layers and reflected back, relative to the light reflected by the semi-reflecting structure. Moreover, the distance of the light-emitting region from the fully reflective surface is chosen to provide constructive interference of generated emitted light (i.e. emitted light rays travelling in the direction of the viewer are in phase with emitted light rays initially travelling away from the viewer and then fully reflected back toward the viewer).

25 Brief Description of the Drawings

Certain preferred embodiments of the present invention will now be explained, by way of example, with reference to the attached Figures in which:

30 Figure 1 shows a side sectional view of light emitting and contrast enhancing layers of an organic electroluminescent device in accordance with a general aspect of the invention;

4

Figure 2 shows a side sectional view of a bottom emission organic electroluminescent device in accordance with one embodiment of the invention; and

Figure 3 shows a side sectional view of a top emission organic electroluminescent
5 device in accordance with a further embodiment of the invention.

Detailed Description of the Invention

Referring now to Figure 1, a semi-reflecting thin film BL 1 is disposed adjacent one
10 side of a microcavity comprising inorganic layers such as ITO, AlSiO, etc. (identified in Figure 1 as Inorganic 1, Inorganic 2) between which are disposed light emitting layers (identified as Organic 1, Organic 2), while a reflective structure BL 2 is disposed adjacent the opposite side of the microcavity. As discussed below in connection with Figures 2 and 3, the layer BL 2 may either be fully reflecting, or may
15 instead partially transmit and phase shift light that is reflected off of a further fully reflective layer (e.g. Al layer). The light emitting layers generate light through electroluminescence and are fabricated from material that is nominally transparent to ambient light entering the device, and which causes a phase shift of that ambient light, as will be discussed in greater detail below.

20

Semi-reflecting structure BL 1 may comprise a single-layer film or a multi-layer film, as discussed in greater detail below, and serves two purposes:

1. It splits the incoming light into a reflected ray and a transmitted ray;
and
- 25 2. It phase shifts the reflected light by about 180° relative to the light reflected from the rear electrode. Note that approximately 10-15% of the light is reflected back towards the viewer.

However, in order to achieve the destructive interference which leads to the device
30 having low reflectance and thus appearing black, the total relative phase shift provided by the organic layers located between the semi-reflecting and reflecting thin films should be about 0° . This net 0° total phase shift occurs as the light travels two

times through the organic layers: once as it is entering the structure and once upon reflection (i.e. $2 \times 180^\circ = 360^\circ = 0^\circ$).

According to the invention, destructive interference of ambient light can be achieved while maintaining constructive interference conditions by choosing the total thicknesses of the organic layers and also any ITO or other inorganic layers, and BL 2 layers (where the BL 2 is only partially reflecting) to provide an approximate net 0° phase shift for light travelling through them, reflecting off of the rear cathode and travelling back out of the device, relative to the light reflected from the semi-reflecting structure in front, while independently controlling the distance between the emitting region at the interface of Organic 1, Organic 2 and the reflective rear electrode.

It should be noted that, in a single film BL 1 structure, light reflected from the first layer is reflected from both the front surface and the rear surface thereof. It is the resulting sum of these 180° phase shifted light rays that cancel, and thus the thickness of this layer is chosen to provide the 180° phase shift. In a multi-layer BL 1 structure, light is reflected from the first layer, phase shifted in the following layer(s), and then reflected off of the following layer(s).

In order to achieve a low reflectance value from the device of Figure 1, the material of BL 1 will generally have some degree of absorption associated with it, i.e. an optical absorption constant k , whereas the optical density is defined by the index of refraction, n . The combination of n , k and thickness is chosen to achieve both the phase shift and the desired degree of reflection.

The combination of the absorption constant k , and the thickness of the BL 1 structure leads to light also being absorbed by the BL 1 structure. This leads to some of the emitted light being absorbed as it exits the device.

The semi-reflective structure BL1 can be located at various places within the device, provided that it is located between the viewer and the light emitting layers Organic 1 and Organic 2, and the total internal phase shift is about 0° relative to the light

reflected from this first semi-reflective structure. For example, there is typically a layer of a transparent conductive material (Inorganic 1) within the device (e.g. Indium Tin Oxide) which serves to conduct current to the device as well as provide a means for the emitted light to escape the device and reach the viewer.

5

Also, semi-reflective structure BL 1 can be located between the viewer and the ITO, or the ITO can be located between the semi-reflective structure BL 1 and the viewer. Particularly in the latter case, the thickness of the ITO is not limited (though it may be selected in relation to desired electrical operation, such as to accord with the operating voltage of the device). In the first case the thickness of the ITO is taken into account to achieve the relative phase shift of about 0° .

10

15

It should also be noted that if the first semi-reflective layer of BL 1 were in contact with the organic layers of the device, these layers would also be selected to have an appropriate work function. On the other hand, a work-function matching layer can also be inserted as part of Inorganic 1, between the semi-reflecting layer and the organic layers.

20

25

30

The organic layers typically consist of a hole injection layer (e.g. TPD) and an electron injection layer (e.g. AlQ3), where light is generated at the interface therebetween. The location of these layers depends on whether the device is a "bottom emission device" (Figure 2) in which the anode is located closest to the viewer, or a "top emission device" (Figure 3) in which the cathode is located closest to the viewer. In either case, in SMOLED devices, the light emitting region is located within 50-200 Å of the interface of these two layers. For constructive interference of the emitted light to occur, the location of this interface relative to the reflective rear electrode is carefully chosen. For destructive interference to occur the total thickness of these layers is also carefully chosen. The various distances can be controlled as well by inserting layers of conductive organic material, typically CuPc, next to either the rear or front electrodes.

Finally, the reflective structure BL 2 consists of either a single layer of metal, for example Aluminum, or a thin film device of several layers, such as is known in the

prior art and which can be tuned to a particular level of reflectance. In the simplest device most light is reflected back to interfere with the light reflected from the first semi-reflecting structure. In another embodiment the reflectivity of the thin film device of several layers can be tuned to ensure that the amplitude of the light reflected from this region is similar to the amplitude of the light reflected from the first semi-reflective structure, noting that some of the light will be absorbed as it passes through the semi-reflective structures.

Also, the light reflected from these rear layers can be phase shifted to enhance the light cancellation, and add a certain degree of freedom to the phase shifting requirements of the other layers, i.e. the organic stack and first semi-reflective structure.

In another embodiment specifically relating to the top emitting structure, the first semi-reflective structure can act as the electrode, eliminating the need for a transparent conducting material, such as ITO. It can also act as a buffer layer to protect underlying organic materials from damaging processes, such as described in commonly-owned Canadian Patent Application No. 2,412,379, entitled TRANSPARENT-CATHODE FOR TOP-EMISSION ORGANIC LIGHT-EMITTING DIODES, the contents of which are incorporated herein by reference.

If the semi-reflecting structure is located in the device in such a manner as to be conducting electricity, it is likely that structure will have to be patterned into the shape of the electrode it is in contact with. However, in another embodiment this structure may be electrically isolated from the structure through the use of an insulating layer. In a top emission structure this requires depositing an insulator on top of the front electrode and then depositing the semi-reflective structure. The thickness of the insulating layer is then taken into account in the phase shift of the transmitted light. In a bottom emission device the semi-reflective structure is deposited onto the substrate along with an insulating layer to isolate it from the front transparent electrode. Again, the thickness of the insulating layer is taken into account in the phase shift of the transmitted light. The advantage is that the semi-reflective

structure is no longer required to be patterned and the optical interference effect occurs between pixels as well as on the pixels themselves.

In another embodiment, if the first semi-reflective structure is itself an insulator the insulating layers can be removed.

In a further embodiment, the organic materials may be comprised of light emitting polymers or inorganic light emitting materials.

Exemplary embodiments are shown in Figures 2 and 3 as follows:

Bottom Emission Device (Figure 2):

The bottom emission device of Figure 2 is fabricated on a substrate of glass or plastic. A semi-reflective (semi-absorbing) structure BL 1 is first deposited on the substrate, followed by a conductive layer of Indium Tin Oxide (ITO). Buffer layer CuPc is then deposited, followed by hole-carrier layer TPD and electron-carrier layer AlQ3. For consistency with Figure 1, a second, fully reflective structure BL 2 is illustrated. However, in practice, the BL 2 structure may be eliminated since full reflection is provided by the final layer of aluminium.

As discussed above, the semi-reflective structure BL'1 partially reflects incident ambient light while partially transmitting ambient light. Ambient light is reflected off the outer surface to create reflected light ray R1. The transmitted light is phase shifted by 90° before partially reflecting off the interface between BL 1 and the ITO layer, whereupon the reflected light is subjected to a further 90° phase shift so that R2 is 180° out of phase with R1, causing destructive interference (i.e. cancellation of the reflected light). Ambient light transmitted through the ITO, CuPC, TPD and AlQ3 layers is subjected to a further 180° phase shift before reflecting off of the BL 2 (or Al) surface, whereupon the reflected light is subjected to a further 180° phase shift, resulting in a net 360° phase shift between ambient light passing inward through the BL 1/ITO interface relative to ambient light passing outward through the BL 1/ITO interface. Consequently, R3 is similar in its phase characteristics to R2 (i.e. R3 is subjected to destructive interference with the incident ambient light). On the other

hand, light generated within the organic layers (i.e. at the interface of hole layer TPD and electron layer AlQ3) is in phase (i.e. R4 and R5 are in phase), so as to benefit from constructive interference.

- 5 Exemplary thicknesses and thickness ranges for the various structural layers are set forth below, wherein it will be noted that several of the layers are completely optional (i.e. thickness of 0). Nonetheless, the overall thickness and materials are chosen to ensure indices of refraction that give rise to a net $360^\circ = 0^\circ$ phase shift for ambient light passing through the layers between BL 1 and the reflecting surface (i.e. BL 2 or
- 10 Al). Equally importantly, the location of the light emissive region at the interface of the TPD and AlQ3 organic layers is chosen to ensure in-phase characteristics for light generated within that region and reflecting with the microcavity structure between the semi-reflective BL 1 structure and the fully reflective BL 2 or Al layer.

- 15 BL 1: Can be a wide range of materials and may comprise one or more layers. Typically the BL 1 structure consists of AlSiO (ratio 3:2, 5.5 nm), SiO₂ (60 nm), and aluminum (10 nm)

- ITO: Typical thickness is about 1200 Å, but within a range of about 0 to about 2500 Å.
- 20 Å.

- CuPc: Typical thickness is about 250 Å, but within a range of about 0 to about 500 Å. The combined thickness of the ITO and CuPC layers should be about 1450 Å to provide a 180° phase shift on a single pass (assuming standard n, k values and that the
- 25 organic materials (TPD and AlQ3) also provide a 180° phase shift).

TPD or Organic 1: preferably about 450 Å, but within a range of 200 -500 Å.

AlQ3 or Organic 2: preferably about 600 Å, but with a range of 200-800 Å.

30

It should be noted that the sum of the thicknesses of ITO, CuPC, TPD and AlQ3 layers is preferably about 2500 Å to allow for a 360° phase shift on two passes

(assuming standard n , k values) of emitted light. The buffer layer, e.g. CuPc, may be used to reduce the thicknesses of the two organic layers.

BL 2: A wide range of materials may be used, including Aluminum Silicon Monoxide. The ratio of aluminum to silicon monoxide must be altered to provide the desired reflectance values. In an optimal device the BL 2 structure may be omitted (i.e. thickness of 0 Å) to get maximum reflection from the rear cathode (Al), as discussed above.

10 Al: approximately 1500 Å.

Top Emission Device (Figure 3):

In the top emission structure of Figure 3, a substrate of glass or plastic is provided onto which a layer of aluminium is deposited to a thickness of about 1200 Å. Next, successive layers of ITO, CuPc, TPD and AlQ3 are deposited to the same thicknesses and approximate specifications as set forth above in connection with Figure 2.

Finally, the BL 1 structure is deposited in from one or more layers, as discussed above in connection with Figure 1. A typical structure consists of AlSiO(ratio 3:2, 5.5 nm), SiO₂ (60 nm), and aluminum (10 nm)

ITO can be used as BL 1 when the optical constants are tailored to meet the desired requirements of a semi-reflecting structure. Aluminum or silver doped ITO is known to increase absorption (conductivity increases as a by-product). In this case, the ITO is about 450 Å thick.

Presently preferred performance of both of the embodiments of Figures 2 and 3 is about 0% reflectance at about 555 nm of visible light, and about 45 to about 50% efficiency as compared to the ideal case of a tuned reflective cathode device without a circular polarizer.

The above-described embodiments of the invention are intended to be examples of the present invention and alterations and modifications may be effected thereto, by those

of skill in the art For example, through careful material selection, the 360 degree phase shift effect (and the 180 degree destructive effect) can be made broadband, extending over the visible range. Specified materials must be selected that have a refractive index that increases with wavelength. AlSiO mixtures give a suitable material set. By inserting specific thicknesses of these materials into the microcavity (e.g. by replacing the ITO or part of the organic materials) the optical thickness of the cavities remains approximately constant for visible wavelengths, (i.e.400nm to 700nm). All such modifications and alterations are believed to be within the scope of the invention as defined by the claims appended hereto.

We claim:

1. An electroluminescent device, comprising a semi-reflecting structure, a reflecting structure, and a plurality of intermediate layers for light generation, wherein said semi-reflecting structure thickness is chosen to cause destructive optical interference of ambient light reflected thereby, and said intermediate layers have thicknesses chosen to create a microcavity for causing constructive optical interference of light generated therein and approximately 360° phase change of transmitted ambient light passing therethrough from said semi-reflecting structure and reflecting off said reflecting structure, such that said transmitted ambient light is subjected to further destructive optical interference within said semi-reflecting structure.
2. The electroluminescent device of claim 1, wherein said intermediate layers include a hole-carrier layer and electron-carrier layer with a light generating region at the interface therebetween.
3. The electroluminescent device of claim 2, wherein said hole-carrier layer comprises TPD and said electron-carrier layer comprises AlQ3.
4. The electroluminescent device of claim 3, wherein said intermediate layers include a buffer layer of CuPC adjacent said TPD layer.
5. The electroluminescent device of claim 4, wherein said intermediate layers include a conductive layer of ITO adjacent said CuPC layer.
6. The electroluminescent device of claim 5, wherein said thicknesses of the intermediate layers are as follows: AlQ3 = 200 to 800 Å, TPD = 200 to 500 Å, CuPC = 0 to 500 Å, ITO = 0 to 2500 Å.
7. The electroluminescent device of claim 1, wherein said semi-reflecting structure comprises at least one layer of Al, SiO2 and Cr.

8. The electroluminescent device of claim 1, wherein said reflecting structure comprises a layer of Al.

5 9. The electroluminescent device of any of claims 1 to 8, wherein said reflecting structure is deposited on a substrate so as to form a top emission device.

10 10. The electroluminescent device of any of claims 1 to 8, wherein said semi-reflecting structure is deposited on a transparent substrate so as to form a bottom emission device.

11. The electroluminescent device of claim 10, wherein said substrate is one of either clear plastic or glass.

15 12. The electroluminescent device of claim 1, wherein said intermediate layers include one of either light emitting polymers or inorganic light emitting materials.

20 13. The electroluminescent device of claim 7, wherein said semi-reflecting structure comprises AlSiO(ratio 3:2, 5.5 nm), SiO₂ (60 nm), and aluminum (10 nm).

14. The electroluminescent device of claim 6, wherein said thicknesses of the intermediate layers are as follows: AlQ₃ = 600 Å, TPD = 450 Å, CuPC = 250 Å, ITO = 1200 Å.

1/3

Figure 1

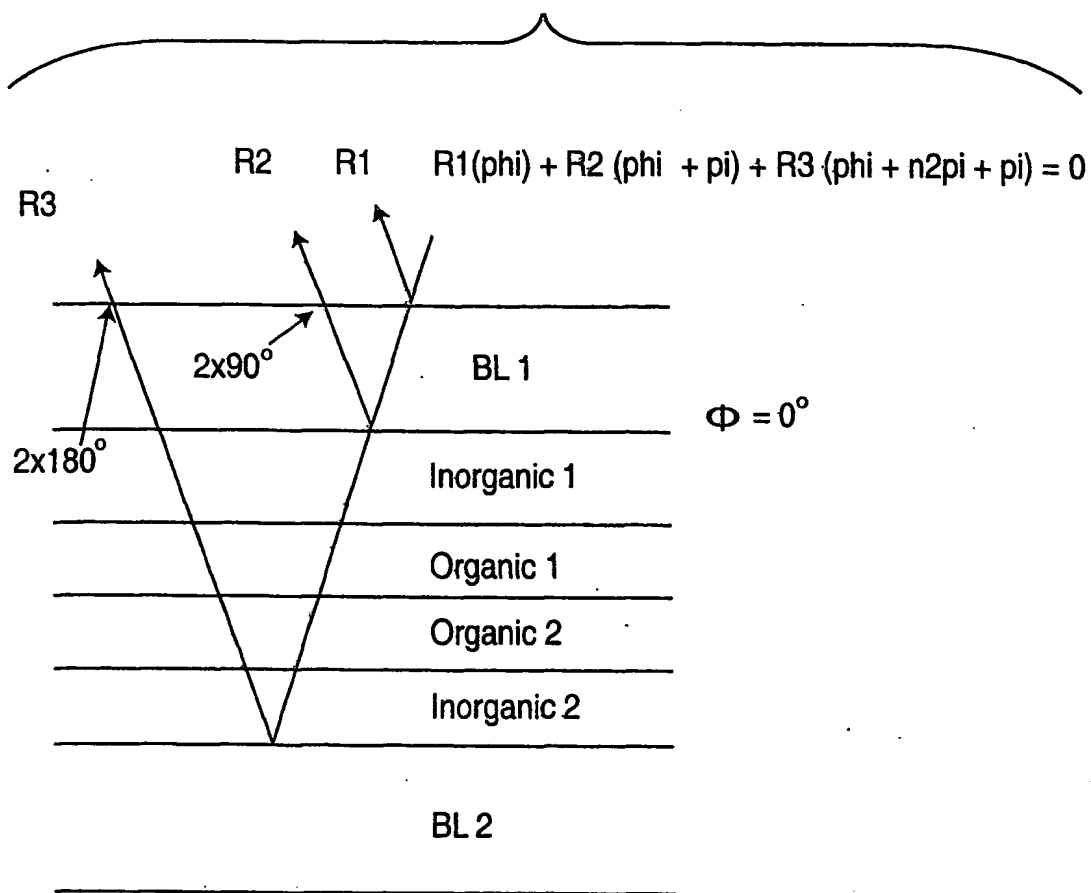
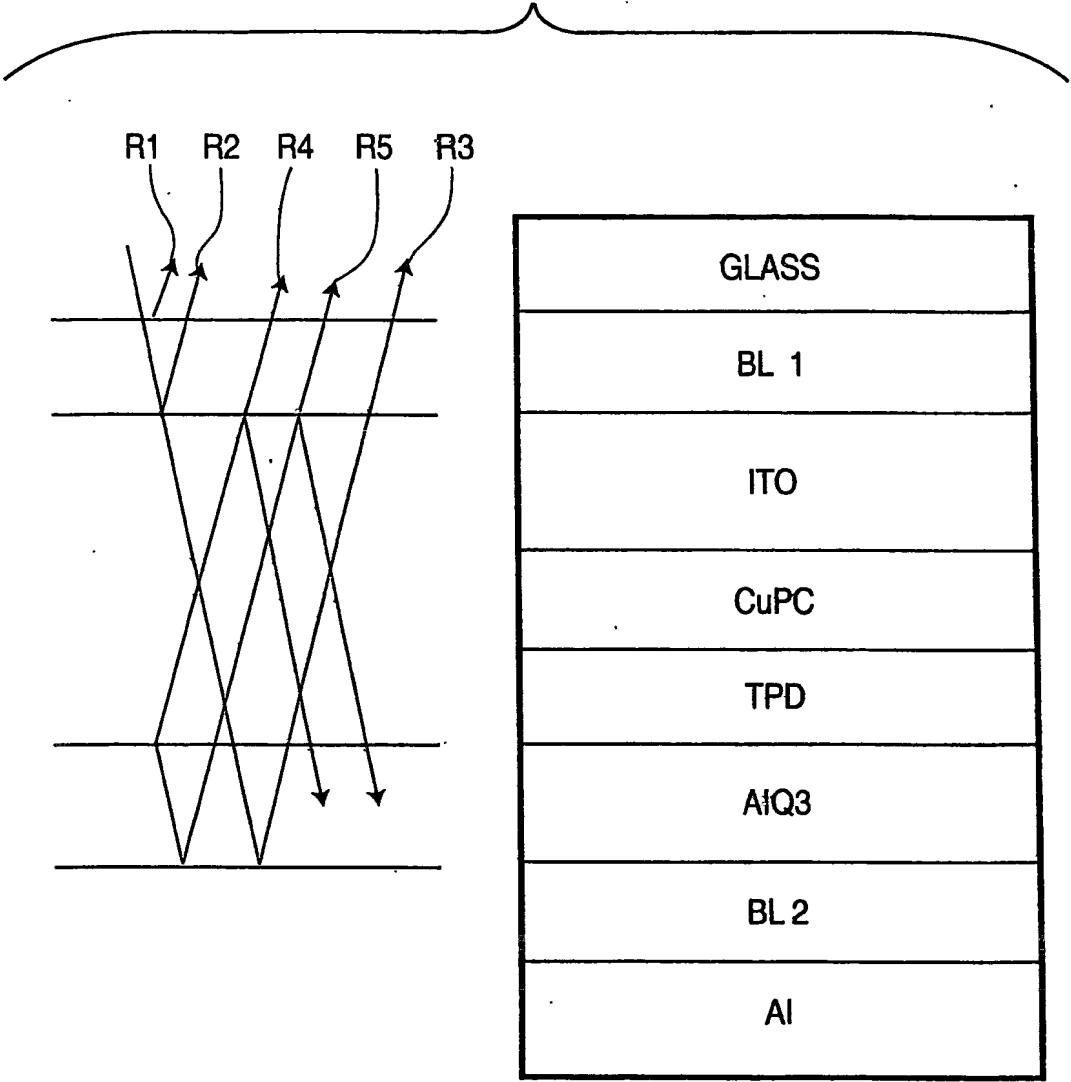
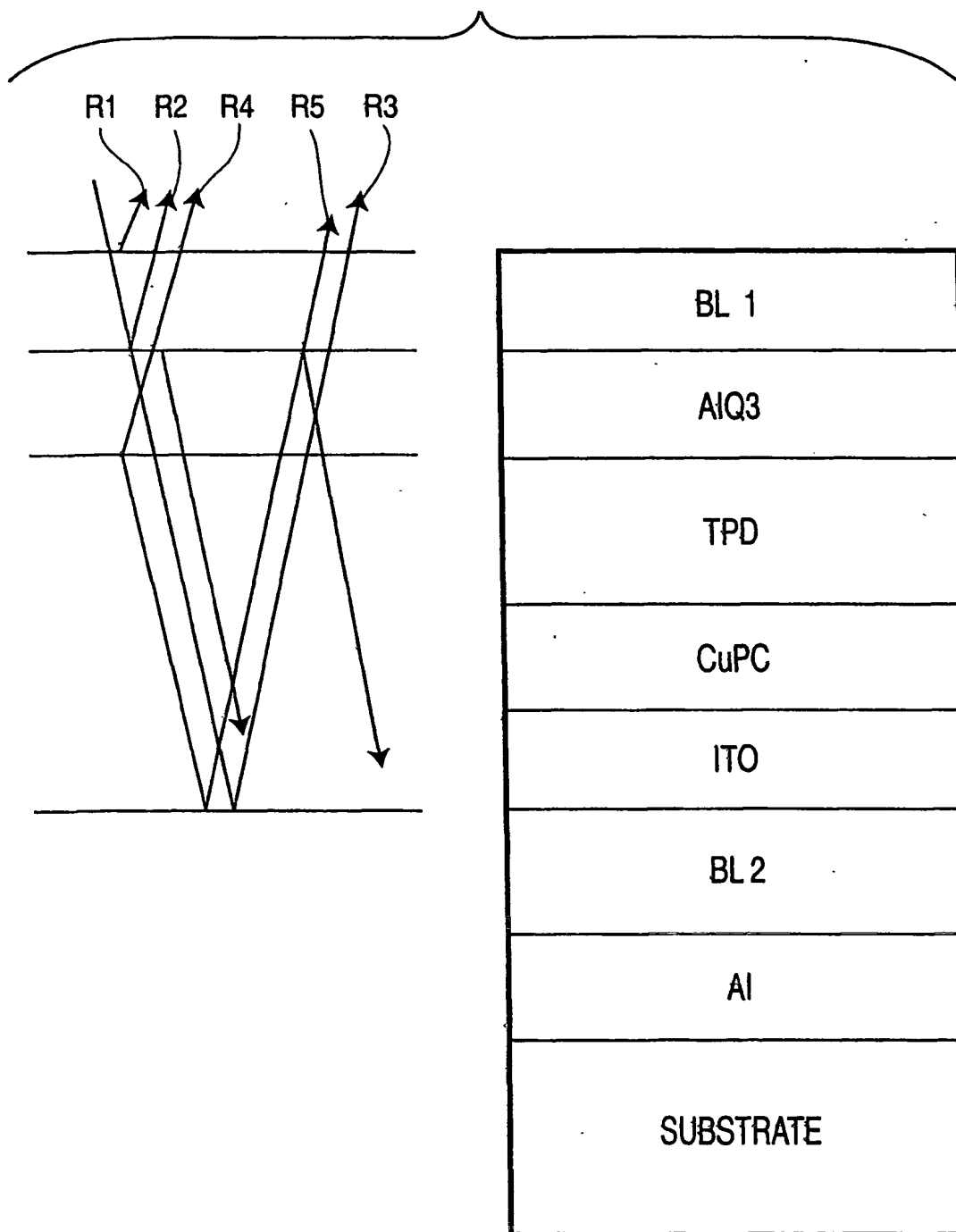


Figure 2



3/3

Figure 3



(19) World Intellectual Property
Organization
International Bureau



(43) International Publication Date
27 May 2004 (27.05.2004)

PCT

(10) International Publication Number
WO 2004/044998 A3

(51) International Patent Classification⁷: **H01L 51/20**
(21) International Application Number:
PCT/CA2003/001742
(22) International Filing Date:
12 November 2003 (12.11.2003)
(25) Filing Language: English
(26) Publication Language: English
(30) Priority Data:
2,411,683 13 November 2002 (13.11.2002) CA

(71) Applicant (for all designated States except US): **LUX-ELL TECHNOLOGIES INC.** [CA/CA]; 2145 Meadowpine Blvd., Mississauga, Ontario L5N 6R8 (CA).

(72) Inventors; and

(75) Inventors/Applicants (for US only): **WOOD, Richard, P.** [CA/CA]; 121 Wellington Street, Delhi, Ontario N4B 1S6 (CA). **JOHNSON, David, J.** [CA/CA]; 60 Chatham Avenue, Toronto, Ontario M4J 1K6 (CA).

(74) Agent: **DE KLEINE, Geoffrey, B., C.**; Sim & McBurney, 330 University Avenue, 6th Floor, Toronto, Ontario M5G 1R7 (CA).

(81) Designated States (*national*): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.

(84) Designated States (*regional*): ARIPO patent (BW, GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IT, LU, MC, NL, PT, RO, SE, SI, SK, TR), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

Published:

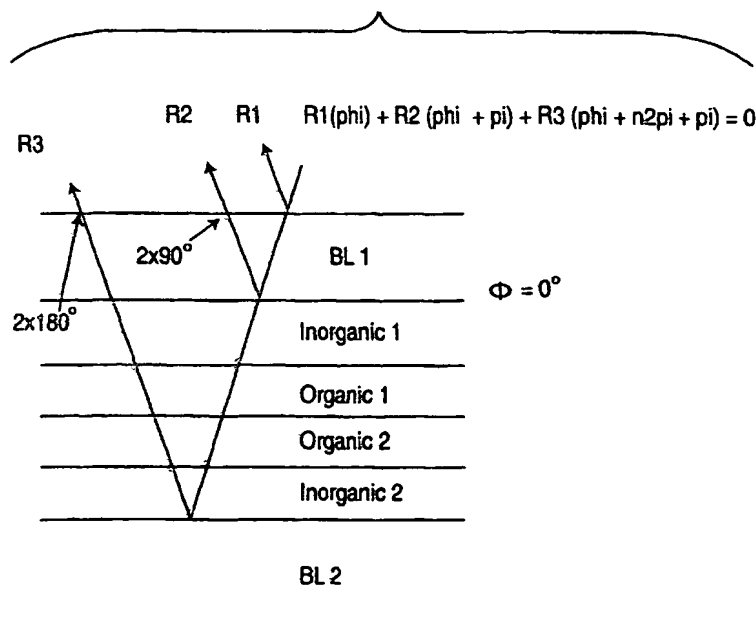
- with international search report
- with amended claims and statement

(88) Date of publication of the international search report:
14 October 2004

Date of publication of the amended claims and statement:
16 December 2004

[Continued on next page]

(54) Title: **ORGANIC LIGHT EMITTING DIODE (OLED) WITH CONTRAST ENHANCEMENT FEATURES**



(57) Abstract: An organic electroluminescent device is provided having emitting layers with materials and thicknesses that provide constructive optical interference of emitted light. The device includes additional layers that provide contrast enhancement through destructive optical interference of ambient light entering the device.

WO 2004/044998 A3



For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

AMENDED CLAIMS

received by the International Bureau on 02 November 2004 (02.11.04) : claims 1 to 14 are unchanged and new claims 15 and 16 have been added.

8. The electroluminescent device of claim 1, wherein said reflecting structure comprises a layer of Al.

9. The electroluminescent device of any of claims 1 to 8, wherein said reflecting structure is deposited on a substrate so as to form a top emission device.

10. The electroluminescent device of any of claims 1 to 8, wherein said semi-reflecting structure is deposited on a transparent substrate so as to form a bottom emission device.

10

11. The electroluminescent device of claim 10, wherein said substrate is one of either clear plastic or glass.

12. The electroluminescent device of claim 1, wherein said intermediate layers include one of either light emitting polymers or inorganic light emitting materials.

13. The electroluminescent device of claim 7, wherein said semi-reflecting structure comprises AlSiO (ratio 3:2, 5.5 nm), SiO₂ (60 nm), and aluminum (10 nm).

20

14. The electroluminescent device of claim 6, wherein said thicknesses of the intermediate layers are as follows: AlQ₃ = 600 Å, TPD = 450 Å, CuPC = 250 Å, ITO = 1200 Å.

15. The electroluminescent device of claim 1, wherein said intermediate layers are selected such that the 360° phase change extends over the visible light range.

16. The electroluminescent device of claim 1, wherein the layers are selected to have a refractive index that increases with wavelength.

30

STATEMENT UNDER ARTICLE 19 (1)

New claims 15 and 16 have been added to further define the present invention. It is believed that these claims are fully supported by the disclosure as originally filed at, for example, page 11.

(19) World Intellectual Property
Organization
International Bureau



(43) International Publication Date
27 May 2004 (27.05.2004)

PCT

(10) International Publication Number
WO 2004/044998 A3

(51) International Patent Classification⁷: **H01L 51/20**

(21) International Application Number:
PCT/CA2003/001742

(22) International Filing Date:
12 November 2003 (12.11.2003)

(25) Filing Language: English

(26) Publication Language: English

(30) Priority Data:
2,411,683 13 November 2002 (13.11.2002) CA

(71) Applicant (for all designated States except US): **LUX-ELL TECHNOLOGIES INC.** [CA/CA]; 2145 Meadowpine Blvd., Mississauga, Ontario L5N 6R8 (CA).

(72) Inventors; and

(75) Inventors/Applicants (for US only): **WOOD, Richard, P.** [CA/CA]; 121 Wellington Street, Delhi, Ontario N4B 1S6 (CA). **JOHNSON, David, J.** [CA/CA]; 60 Chatham Avenue, Toronto, Ontario M4J 1K6 (CA).

(74) Agent: **DE KLEINE, Geoffrey, B., C.**; Sim & McBurney, 330 University Avenue, 6th Floor, Toronto, Ontario M5G 1R7 (CA).

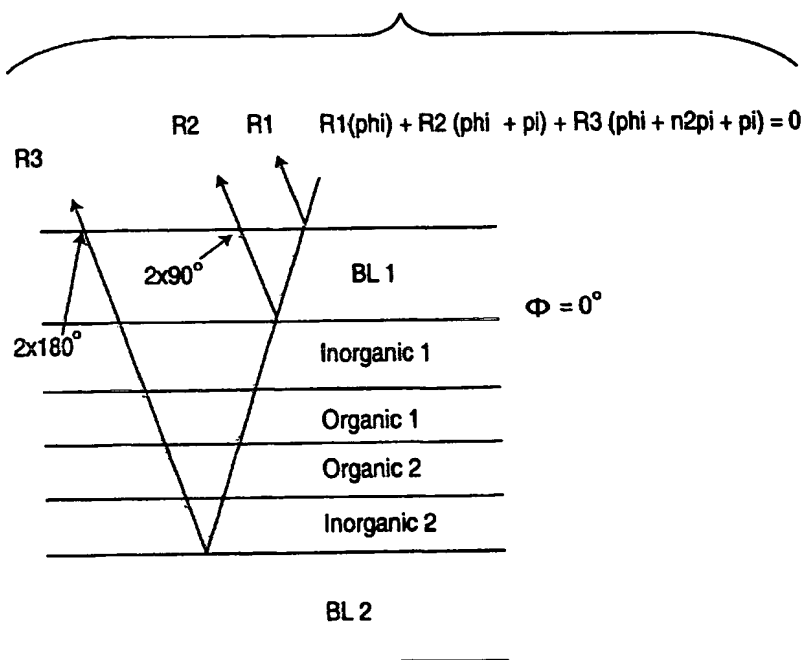
(81) Designated States (national): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.

(84) Designated States (regional): ARIPO patent (BW, GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IT, LU, MC, NL, PT, RO, SE, SI, SK, TR), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

Published:
— with international search report

[Continued on next page]

(54) Title: **ORGANIC LIGHT EMITTING DIODE (OLED) WITH CONTRAST ENHANCEMENT FEATURES**



(57) Abstract: An organic electroluminescent device is provided having emitting layers with materials and thicknesses that provide constructive optical interference of emitted light. The device includes additional layers that provide contrast enhancement through destructive optical interference of ambient light entering the device.

WO 2004/044998 A3



— *before the expiration of the time limit for amending the claims and to be republished in the event of receipt of amendments*

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

(88) Date of publication of the international search report:
14 October 2004

INTERNATIONAL SEARCH REPORT

International Application No

PCT/CA 03/01742

A. CLASSIFICATION OF SUBJECT MATTER

IPC 7 H01L51/20

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC 7 H01L

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

EPO-Internal, PAJ, INSPEC, WPI Data

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
Y	US 6 411 019 B1 (HOFSTRA PETER G ET AL) 25 June 2002 (2002-06-25) cited in the application column 9, line 42 - column 10, line 2 -----	1,8, 10-12
A	SO S K ET AL: "Interference effects in bilayer organic light-emitting diodes" APPLIED PHYSICS LETTERS, AMERICAN INSTITUTE OF PHYSICS. NEW YORK, US, vol. 74, no. 14, 5 April 1999 (1999-04-05), pages 1939-1941, XP012022322 ISSN: 0003-6951 the whole document ----- -/--	1-3

☒ Further documents are listed in the continuation of box C.☒ Patent family members are listed in annex.

* Special categories of cited documents:

- *A* document defining the general state of the art which is not considered to be of particular relevance
- *E* earlier document but published on or after the international filing date
- *L* document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)
- *O* document referring to an oral disclosure, use, exhibition or other means
- *P* document published prior to the international filing date but later than the priority date claimed

T later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention

X document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone

Y document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art

G document member of the same patent family

Date of the actual completion of the international search

26 August 2004

Date of mailing of the international search report

03/09/2004

Name and mailing address of the ISA

European Patent Office, P.B. 5818 Patentlaan 2
NL - 2280 HV Rijswijk
Tel. (+31-70) 340-2040, Tx. 31 651 epo nl,
Fax (+31-70) 340-3016

Authorized officer

De Laere, A

INTERNATIONAL SEARCH REPORT

International Application No

PCT/CA 03/01742

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to Claim No.
A	US 5 049 780 A (DOBROWOLSKI JERZY A ET AL) 17 September 1991 (1991-09-17) cited in the application the whole document	1
P,Y	CA 2 422 895 A (LUXELL TECHNOLOGIES INC) 6 November 2003 (2003-11-06) cited in the application	1,8, 10-12
P,A	paragraphs '0023!, '0024!, '0033! -----	2-7,9, 13,14

INTERNATIONAL SEARCH REPORT

Information on patent family members

International Application No

PCT/CA 03/01742

Patent document cited in search report		Publication date	Patent family member(s)	Publication date
US 6411019	B1	25-06-2002	AU 6256500 A	13-02-2001
			WO 0108240 A1	01-02-2001
			CA 2378442 A1	01-02-2001
			CN 1369116 T	11-09-2002
			EP 1208611 A1	29-05-2002
			EP 1300891 A1	09-04-2003
			JP 2003505849 T	12-02-2003
			US 2004052931 A1	18-03-2004
			US 2003127971 A1	10-07-2003
			US 2002153834 A1	24-10-2002
			US 2002039871 A1	04-04-2002
US 5049780	A	17-09-1991	CA 1302547 C	02-06-1992
			AT 141035 T	15-08-1996
			DE 68926906 D1	05-09-1996
			DE 68926906 T2	27-02-1997
			EP 0372763 A2	13-06-1990
			JP 2276191 A	13-11-1990
			JP 2529741 B2	04-09-1996
CA 2422895	A	06-11-2003	WO 03094254 A2	13-11-2003
			CA 2422895 A1	06-11-2003

**This Page is Inserted by IFW Indexing and Scanning
Operations and is not part of the Official Record.**

BEST AVAILABLE IMAGES

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images include but are not limited to the items checked:

- ☒ **BLACK BORDERS**
- ☐ **IMAGE CUT OFF AT TOP, BOTTOM OR SIDES**
- ☐ **FADED TEXT OR DRAWING**
- ☐ **BLURRED OR ILLEGIBLE TEXT OR DRAWING**
- ☐ **SKEWED/SLANTED IMAGES**
- ☐ **COLOR OR BLACK AND WHITE PHOTOGRAPHS**
- ☐ **GRAY SCALE DOCUMENTS**
- ☒ **LINES OR MARKS ON ORIGINAL DOCUMENT**
- ☒ **REFERENCE(S) OR EXHIBIT(S) SUBMITTED ARE POOR QUALITY**
- ☐ **OTHER: _____**

IMAGES ARE BEST AVAILABLE COPY.

As rescanning these documents will not correct the image problems checked, please do not report these problems to the IFW Image Problem Mailbox.